

Description

The NTD4804NT4G uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

D S S

TO-252-2L (DPAK)

General Features

V_{DS} = 30V I_D =120A

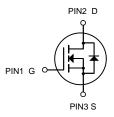
 $R_{DS(ON)}$ < 3.8m Ω @ V_{GS} =10V

Application

Battery protection

Load switch

Uninterruptible power supply



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
NTD4804NT4G	TO-252-2L(DPAK)	HXY MOSFET	2500

Absolute Maximum Ratings (T_C=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units	
V _{DS}	Drain-Source Voltage	30	V	
Vgs	Gate-Source Voltage	±20	V	
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	t, V _{GS} @ 10V ¹ 120		
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	Continuous Drain Current, V _{GS} @ 10V ¹ 75		
Івм	Pulsed Drain Current ²	Pulsed Drain Current ² 384		
EAS	Single Pulse Avalanche Energy ³	196	mJ	
las	Avalanche Current	Current 53.8		
P _D @T _C =25°C	Total Power Dissipation ⁴	62.5		
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
ReJA	Thermal Resistance Junction-Ambient ¹	62	°C/W	



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit	
Static Ch	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V, I_{DS} =250 μ A	30	-	-	V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V	-	-	1	μΑ	
		T _J =85°C	-	-	30		
$V_{\rm GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	1.4	1.7	2.5	V	
$I_{\rm GSS}$	Gate Leakage Current	V_{GS} =±20V, V_{DS} =0V	-	-	±100	nA	
	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =20A	-	3	3.8		
$R_{\text{DS(ON)}}^{}^{\text{d}}}$		T _J =125°C	-	4.4	-	mΩ	
		V_{GS} =4.5V, I_{DS} =15A	-	4.0	5.5		
Gfs	Forward Transconductance	V_{DS} =5V, I_{DS} =10A	-	24.6	-	S	
Diode Ch	aracteristics						
V _{SD} d	Diode Forward Voltage	I _{SD} =20A, V _{GS} =0V	-	0.8	1.1	V	
t _{rr}	Reverse Recovery Time		-	35.6	-		
t _a	Charge Time	1 =20A dl /dt=100A/	-	19.3	-	ns	
t _b	Discharge Time	I_{DS} =20A, dI_{SD}/dt =100A/ μ s	-	16.3	-		
Q _{rr}	Reverse Recovery Charge		-	26	-	nC	
Dynamic	Characteristics ^e						
R_{G}	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	1	2	Ω	
C _{iss}	Input Capacitance	V _{GS} =0V,	-	2485	2971	pF	
C _{oss}	Output Capacitance	V _{DS} =15V,	-	850	-		
C _{rss}	Reverse Transfer Capacitance	Frequency=1.0MHz	-	85	-		
t _{d(ON)}	Turn-on Delay Time		-	12.4	23		
t _r	Turn-on Rise Time	V_{DD} =15V, R_L =15 Ω ,	-	9.5	18	ns	
$t_{d(OFF)}$	Turn-off Delay Time	I_{DS} =1A, V_{GEN} =10V, R_{G} =6 Ω	-	27.2	49		
t _f	Turn-off Fall Time		-	35.2	64		
Gate Cha	rge Characteristics ^e						
Q_g	Total Gate Charge	V _{DS} =15V, V _{GS} =10V, I _{DS} =20A	-	20.6	28.8		
Q_g	Total Gate Charge		-	9.8	-		
\mathbf{Q}_{gth}	Threshold Gate Charge	V _{DS} =15V, V _{GS} =4.5V,	-	1.8	-	nC	
Q_{gs}	Gate-Source Charge	I _{DS} =20A	-	3.8	-		
Q_{gd}	Gate-Drain Charge		-	3.7	-		

Note d : Pulse test ; pulse width≤300 μ s, duty cycle≤2%.

Note e : Guaranteed by design, not subject to production testing.



Typical Operating Characteristics

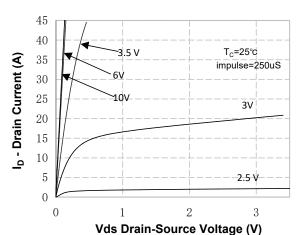


Figure 1. On-Region Characteristics

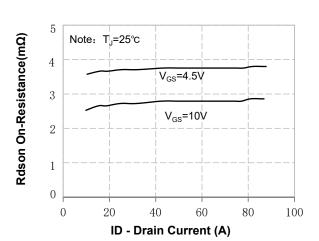
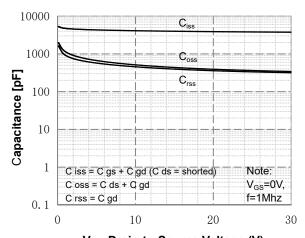


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage



V_{DS} Drain-to-Source Voltage (V) Figure 5. Capacitance Characteristics

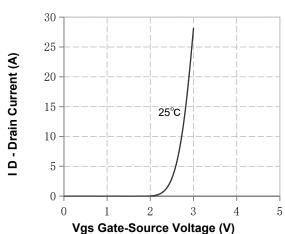


Figure 2. Transfer Characteristics

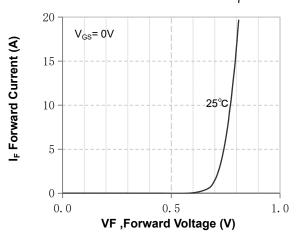


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

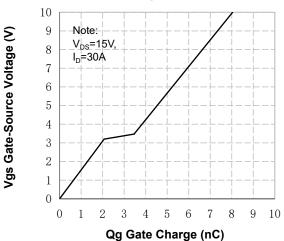


Figure 6. Gate Charge Characteristics

 10^{3}

 10^{2}

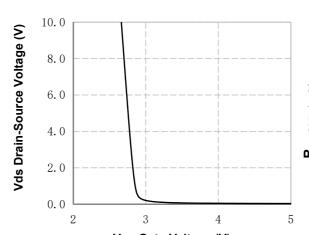
 10^{1}

 10^{0}

 10^{-1}

0.1

D - Drain Current (A)



Vgs Gate-Voltage (V)
Figure 7. Vds Drain-Source Voltage
vs Gate Voltage

Operation in this are a is Limited by R_{DS(on}

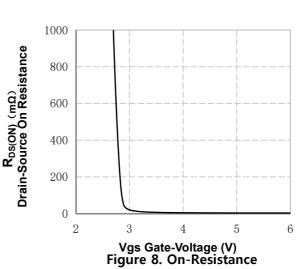




Figure 9. Maximum Safe Operating Area

Vds Drain-Source Voltage (V)

ШШ

10

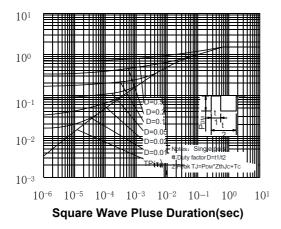
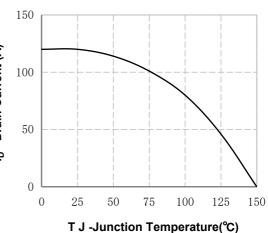


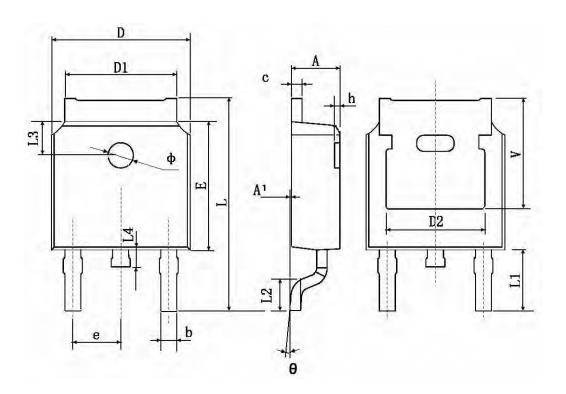
Figure 11. Transient Thermal Response Curve



vs Gate Voltage

Figure 10. Maximum Continuous Drain Current vs Temperature

TO-252-2L(DPAK) Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	0.483 TYP.		0.190 TYP.		
Е	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.900 TYP.		0.114 TYP.		
L2	1.400	1.700	0.055	0.067	
L3	1.600 TYP.		0.063 TYP.		
L4	0.600	1.000	0.024	0.039	
Ф	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.350 TYP. 0.211 TYP.		TYP.		



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